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Bldg 410

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19. Abstract, (cont)

Nine papers were published in refreed journals. Thirteen papers are either submitted to refreed journals or are under preparation. Abstracts of five papers were presented to domestic and international conferences. Dissociative attachment and polar dissociation cross sections were measured for the following molecules: HCl. NO, M20, C6H6, S1H4, S12H6, and L1H. Direct ionization and dissociative ionization cross sections were determined for the following molecules: H2, D2, N2, O2, He, Ne, Ar, Kr, Xe, H2O, CO, CO2, CH4, S1H4, S1H4, S12H6, N2*, and NH3. An experimental apparatus for a pulsed extraction technique was fabricated and successfully tested. Keywords; Electron Impart Spectras Hydrogen Chlorida. Direcce Ox des; Nitrous Oxide; Ben gene, Vane, Disilane, Lithium Kydride. God oger Doute; um: Notrogen, Oxygen Herun; Wean; Argon, Krypton, Kenon, Witer Carpon Monoxide Carpon Dioxide, Methane, Known [hd)

AFOSR-TR. 89-1102

FINAL REPORT

ON

THE PROPOSAL ENTITLED" ION FORMATION BY ELECTRON IMPACT"

JPL Task plan No. 80-2501

Period of Performance: 5/31/85 to 11/30/88

Principal Investigator: Santosh K. Srivastava

AFOSR-ISSA-85-0070

AFOSR-ISSA-86-0036

AFOSR-ISSA-87-0036

AFOSR-ISSA-88-0014

FINAL REPORT ON THE PROPOSAL ENTITLED "ION FORMATION BY ELECTRON IMPACT"

Principal Investigator: Santosh K. Srivastava

The period of performance for the above mentioned task was from 5/31/85 to 11/30/88. During this period the following was accomplished:

- 1) Nine papers were published in refreed journals. (A list is attached here).
- 2) Thirteen papers are either submitted to refreed journals or are under preparation. (A list is attached here).
- 3) Abstracts of five papers were presented in domestic and international conferences.
- 4) One united states patent was granted on an electron gun developed under the reseach sponsored by AFOSR.
- 5) One united states patent filed and is pending.
- 6) Dissociative attachment and polar dissociation cross sections were measured for the following molecules:
 - i) HCl (fig.1).
 - ii) NO (fig.2).
 - iii) N₂O (fig.3,4).
 - iv) C₆H₆ (fig.5).
 - v) SiH4 (fig.6,7).
 - vi) Si₂H₆(fig.8,9).
 - vii) LiH (fig.10,11).
- 7) Direct ionization and dissociative ionization cross sections were determined for the following moistules:
 - i) H₂ (fig. 12,13).
 - ii) D₂ (fig. 14,15).
 - iii) N₂ (fig.16,17).
 - iv) O₂ (fig.18,19,20).
 - v) He (fig. 21).
 - vi) Ne (fig. 22,23,24).
 - vii) Ar (fig. 25,26,27).
- viii) Kr (Fig. 28,29,30).
 - ix) Xe (Fig. 31,32,33).
 - x) H_2O (Fig. 34,35,36)
 - xi) CO (Fig. 37).
- xii) CO₂ (fig. 38,39).



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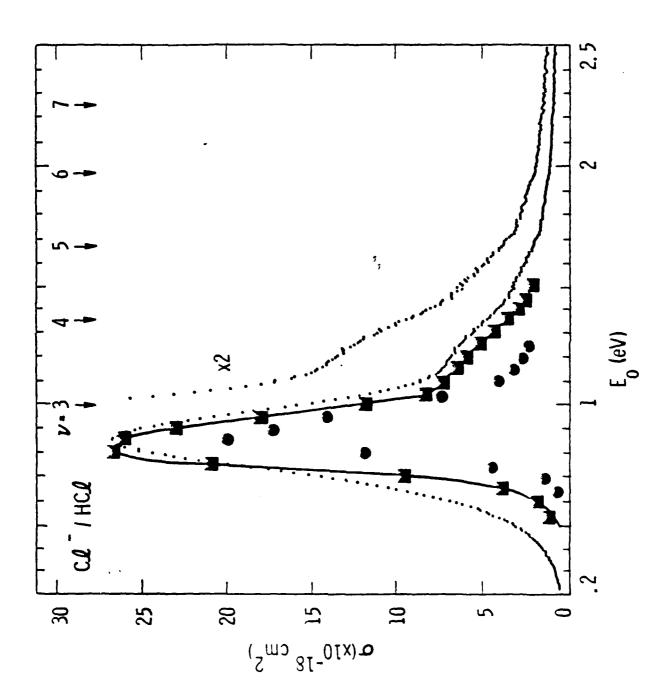
- xiii) CH4 (fig. 40,41).
- xiv) SiH₄ (fig. 42).
- xv) Si_2H_6 (fig. 43,44).
- xvi) N₂* (fig. 45).
- xvii) CH₃ (fig. 46).
- 8) An experimental apparatus for a pulsed extraction technique was fabricated and successfully tested.

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- 6. S. K. Srivastava, "Present Status of the Measured Dissociative Attachment Cross Sections", invited paper to appear in the "Production and Neutralization of Negative Ions and Beams" (Fourth International Symposium, Brookhaven, 1986). ed. J. Alessi, Am. Inst. Phys., 1987.
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- 9. D. P. Wang, L. C. Lee and S. K. Srivastava, "Electron Impact Ionization of CH₃ in 10-22 eV", Chem. Phys. Lett. 152, 513 (1988).

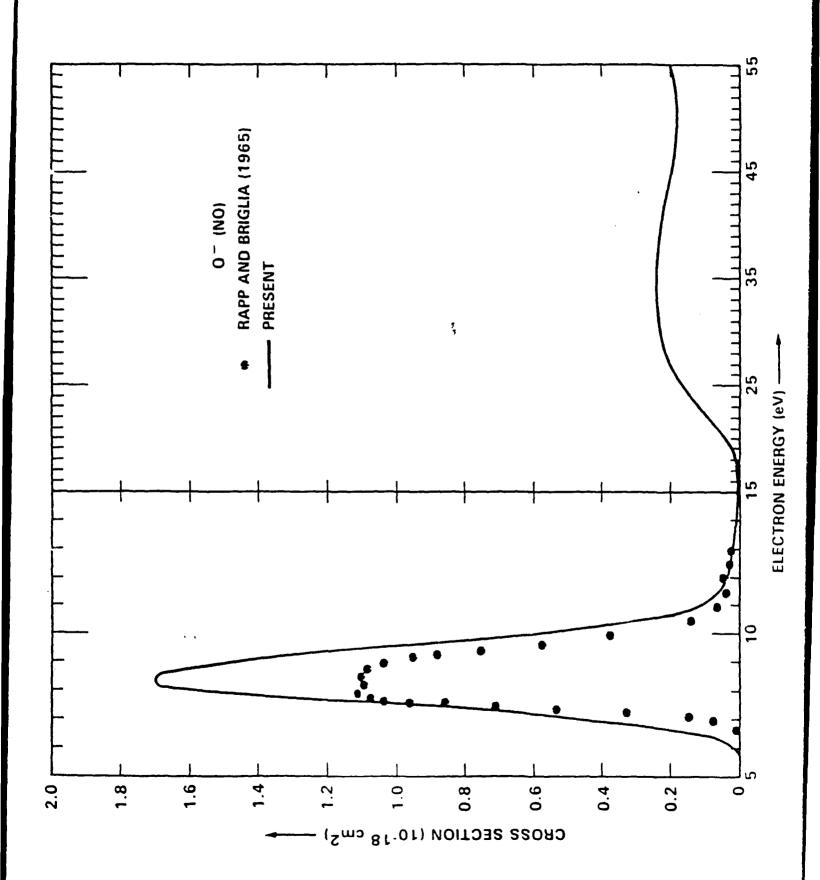
PAPERS UNDER PREPARATION

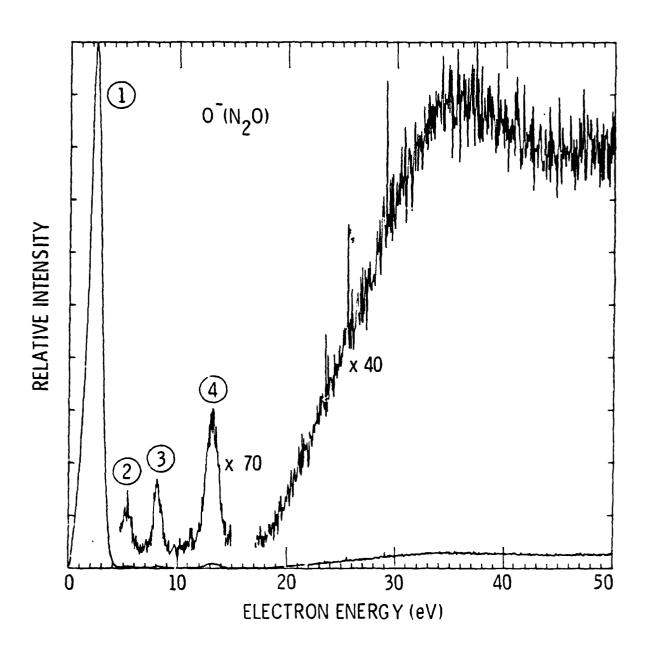
- 1. K. Krishnakumar and S. K. Srivastava, "Cross Sections for the Production of N_2^+ , $N^+ + N_2^+$, and N_2^+ by Electron Impact on N_2 ", submitted to J. Phys. B.
- 2. E. Krishnakumar and S. K. Srivastava, "Dissociative Attachment of Electrons to N₂0", submitted by J. Phys. B.
- 3. E. Krishnakumar and S. K. Srivastava, "Cross Sections for Positive Ion Production by Electron Impact on SiH₄ and Si₂H₆", under preparation.
- 4. E. Krishnakumar and S. K. Srivastava, "Ionization of O₂ by Electron Impact", under preparation.
- 5. E. Krishnakumar and S. K. Srivastava, "Measurement of Cross Sections for the Production of Positive Ions from H₂ and D₂ by Electron Impact", under preparation.
- 6. E. Krishnakumar, M. T. Bernius and S. K. Srivastava, "An Instrument for the Measurement of Dissociative Ionization and Attachment Cross Sections of Molecules by Electron Impact", under preparation.
- 7. C. A. de Souza, E. Krishnakumar and S. K. Srivastava, "Dissociative Attachment of Electrons with CH₄ and SiH₄", under preparation.
- 8. E. Krishnakumar, I. Iga and S. K. Srivastava, "Dissociative Attachment of Electrons with Si₂H₆", under preparation.
- 9. D. P. Wang, L. C. Lee and S. K. Srivastava, "Dissociative Ionization of Laser Excited N₂ by Electron Impact", accepted J. Quant. Spectr. and Rad. Trans.
- 10. E. Krishnakumar and S. K. Srivastava, "Cross Sections for the Production of Positive Ions by Electron Impact on SIH₄ and Si₂H₆". To be published in *Phys. Rev. A*.
- 11. E. Krishnakumar and S. K. Srivastava, "Negative Ion Formation by Electron Impact on Si₂H₆'". To be published in *Phys. Rev. A*.
- 12. S. K. Srivastava, "Negative and Positive Ions from LiH Vapor", under preparation.
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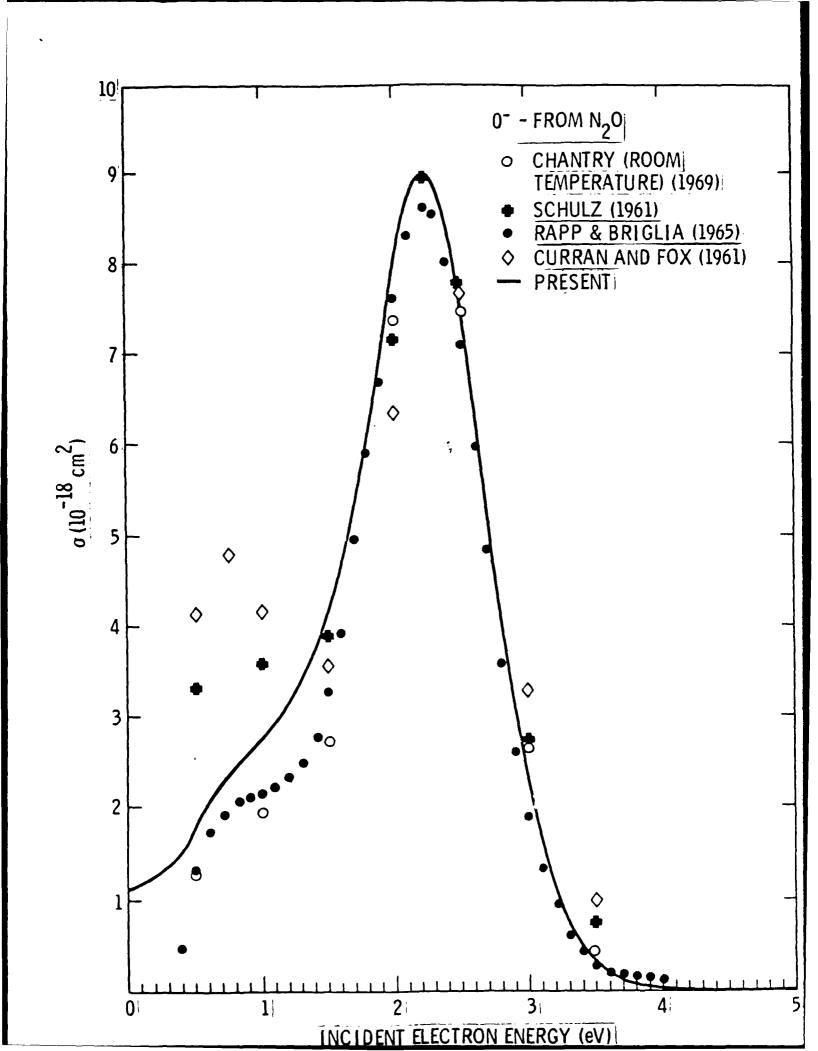


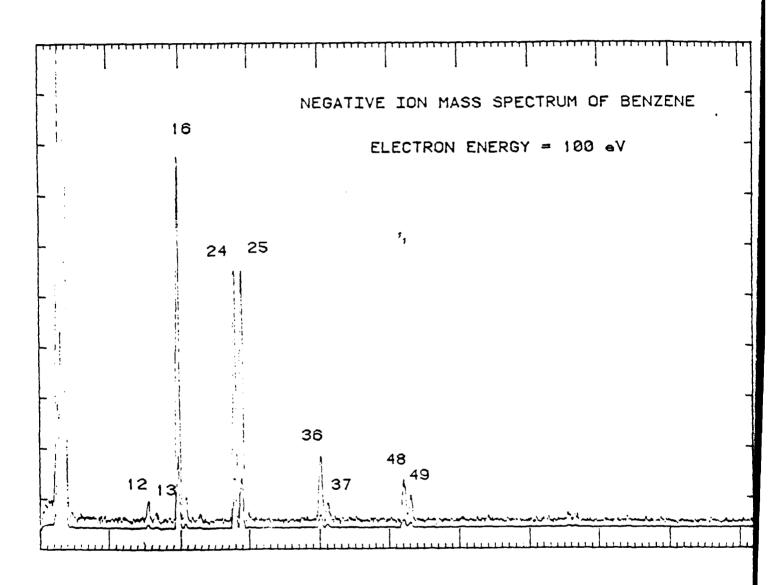
Dissociative electron attachment cross section for CL-/HCL as a function of the electron beam energy. The arrows indicate the position of the vibrational levels of the HCL $^{1}\Sigma^{+}$ ground

Figure 1.

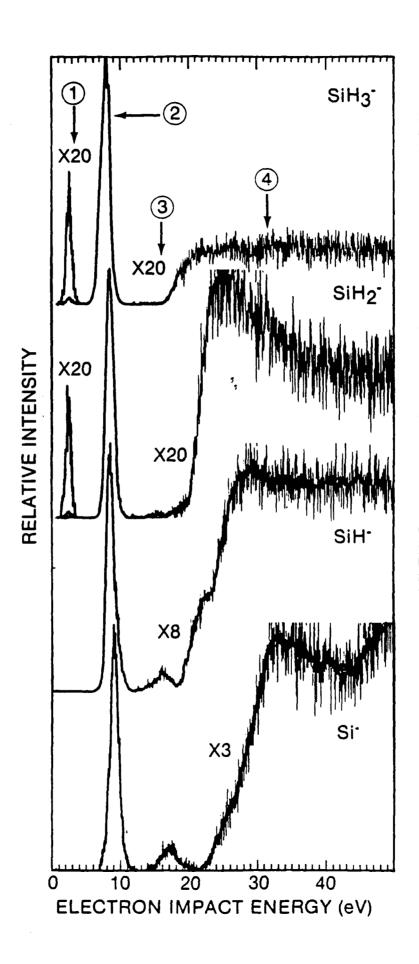


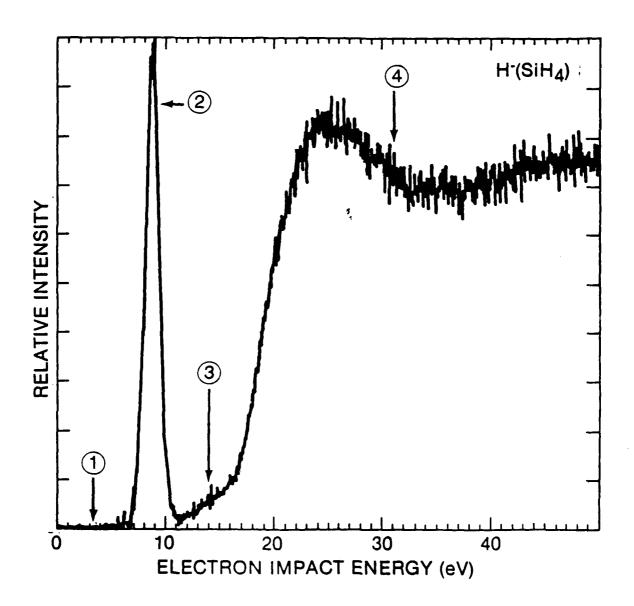


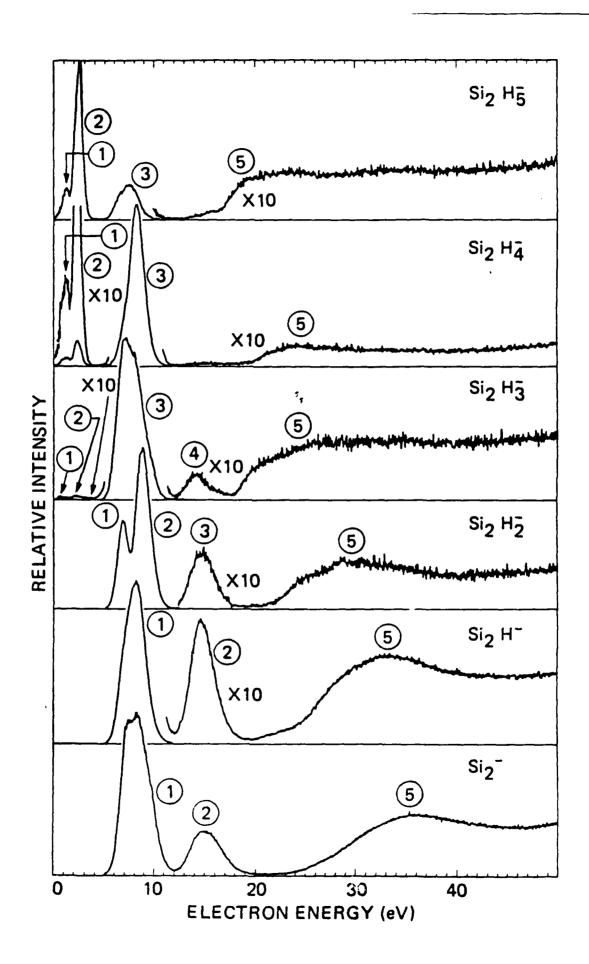


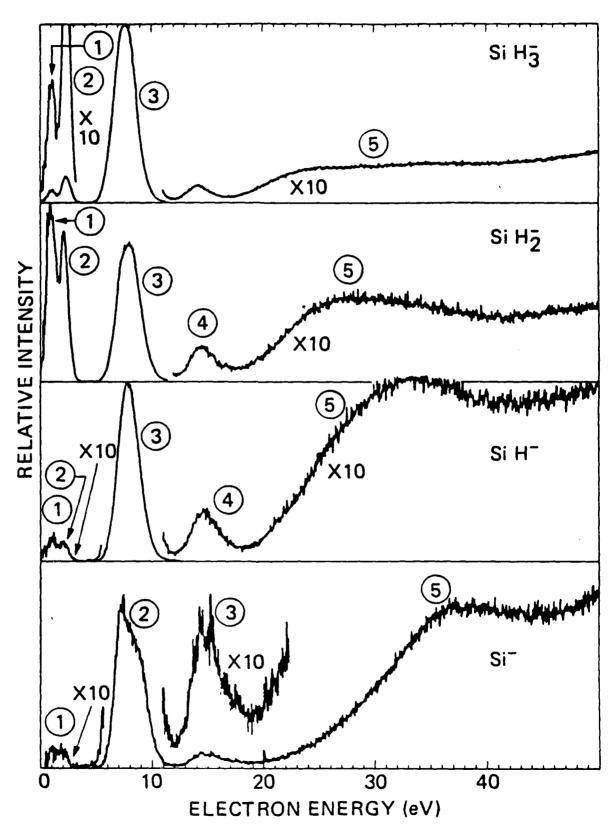


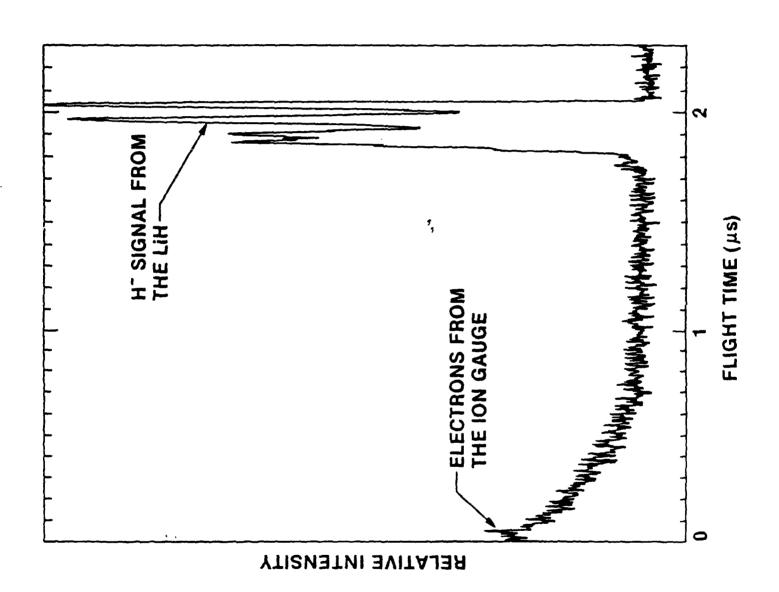
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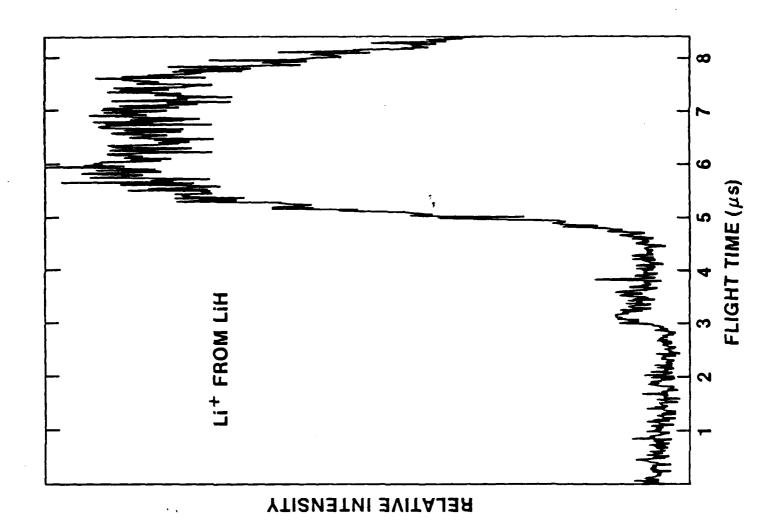


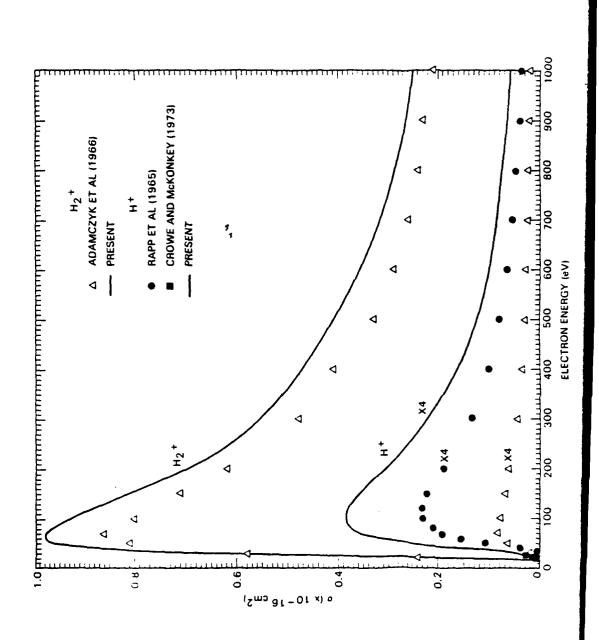


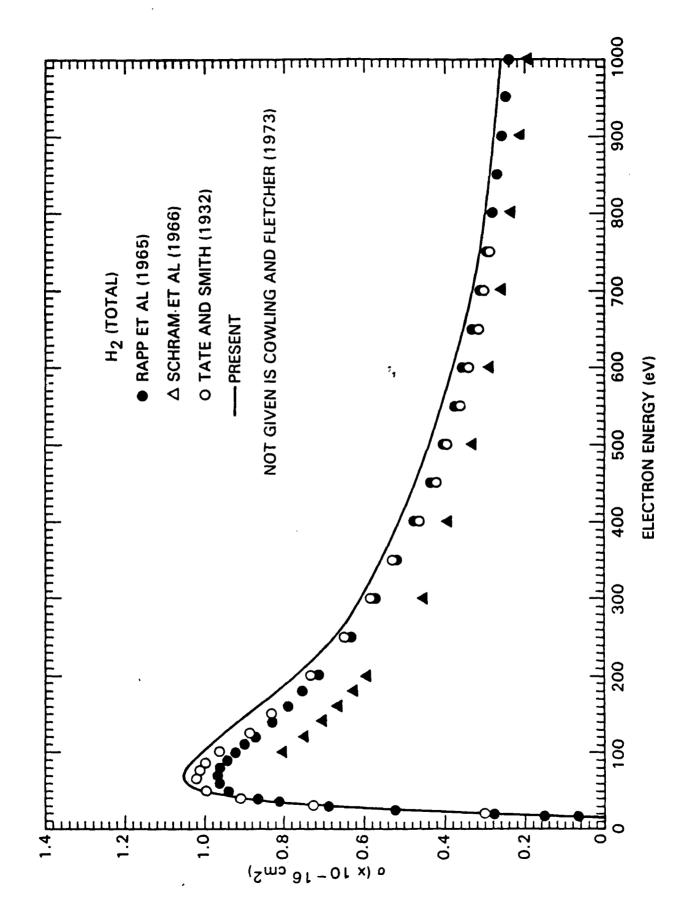


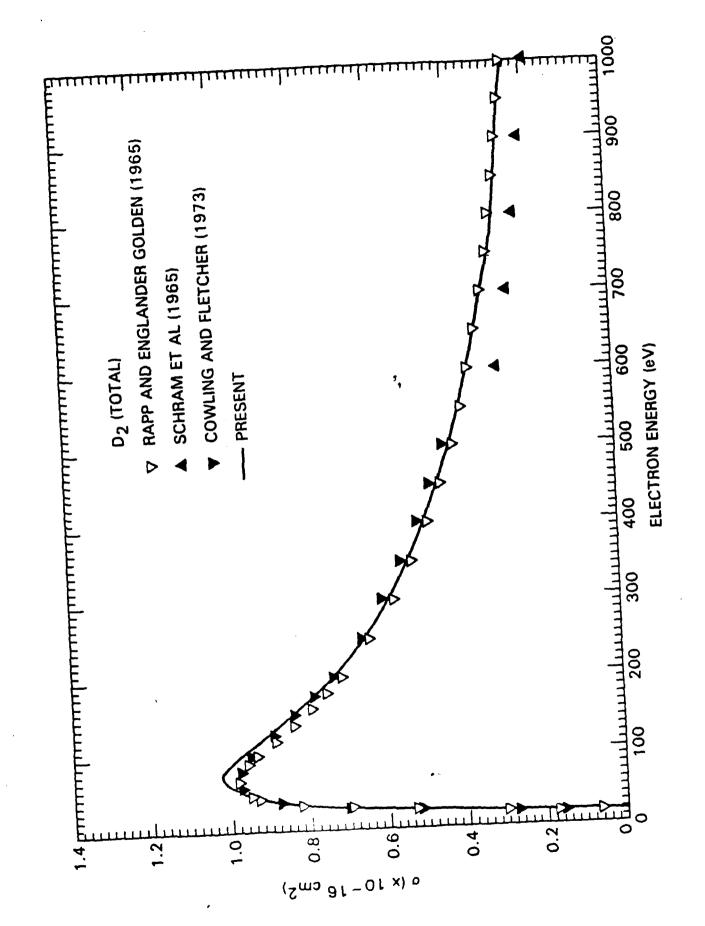


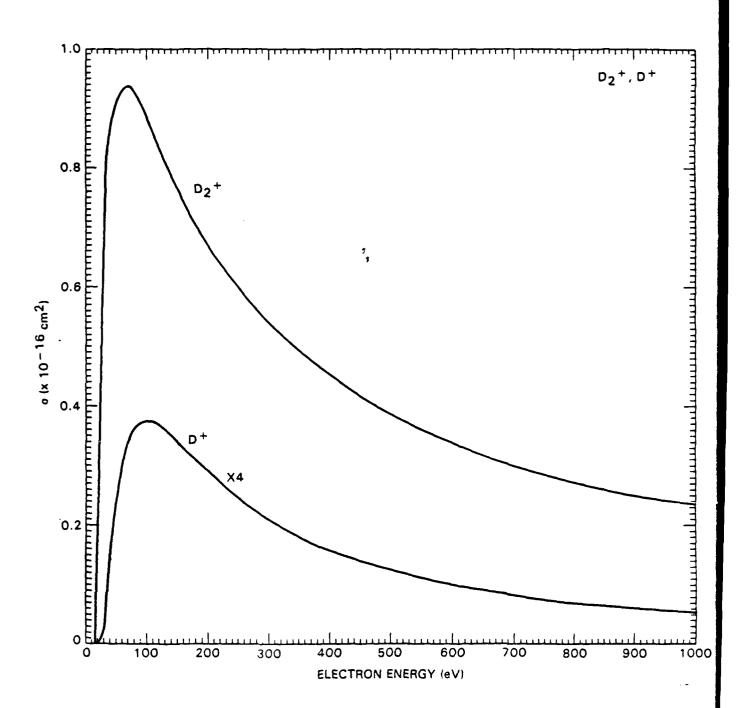


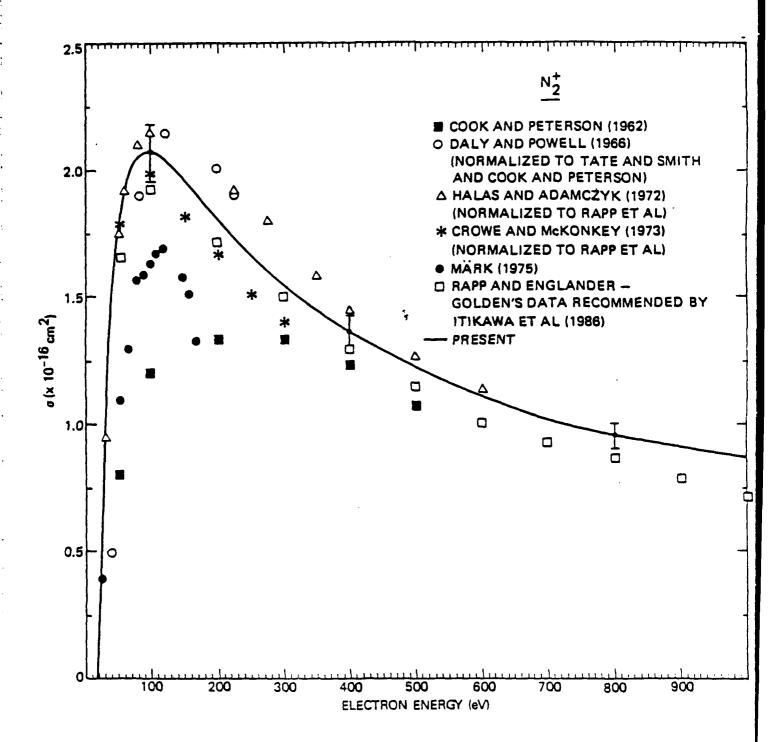


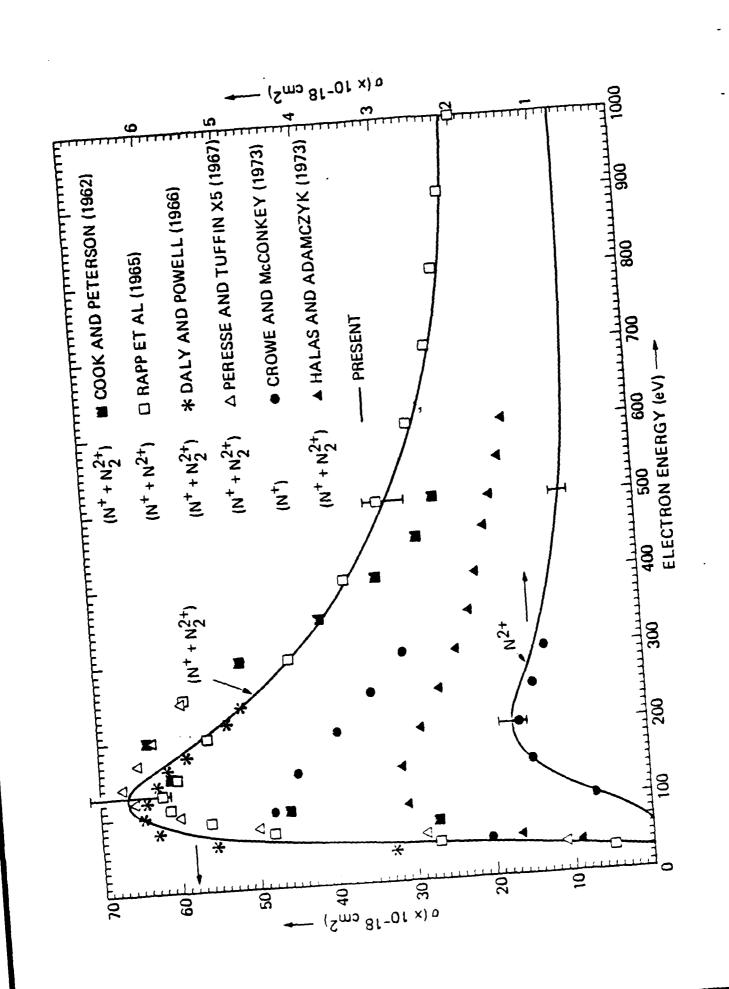


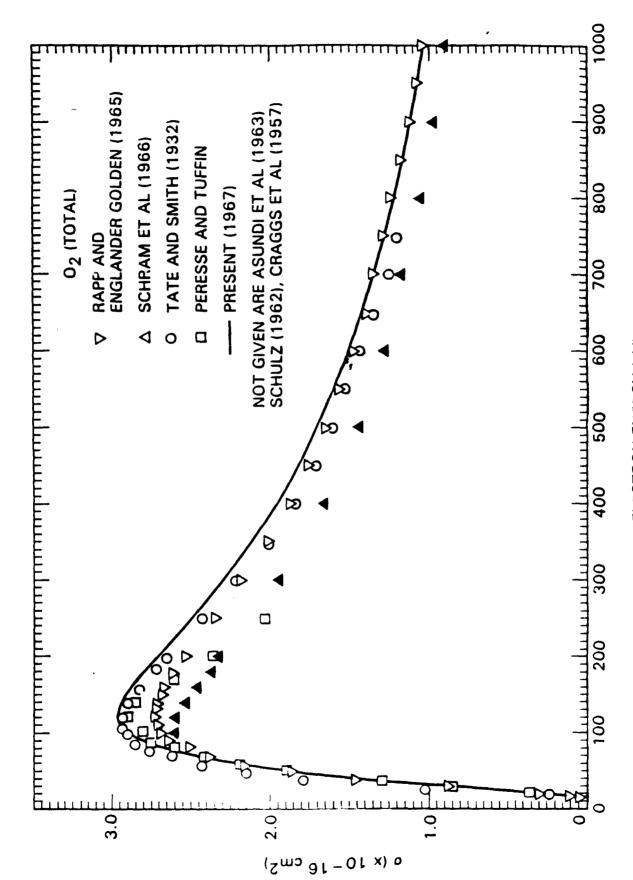




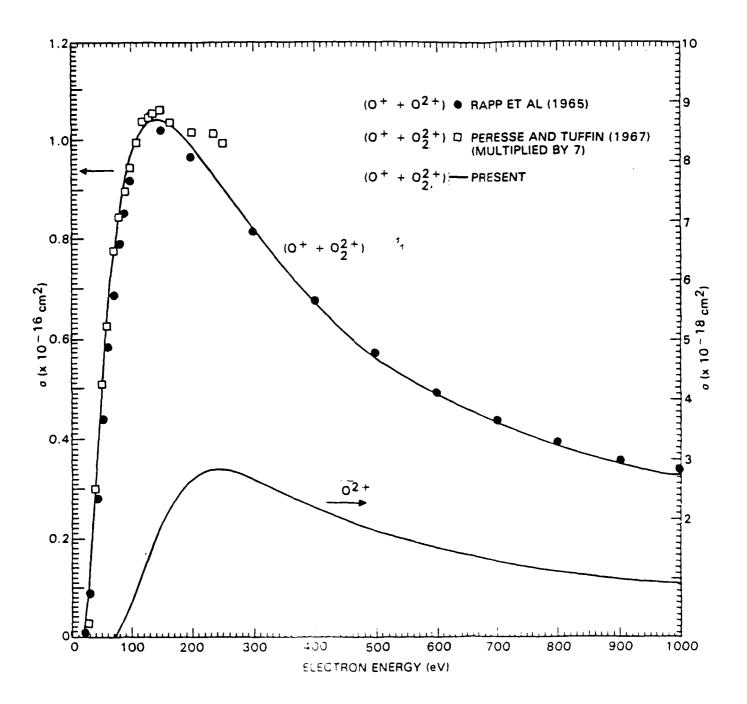


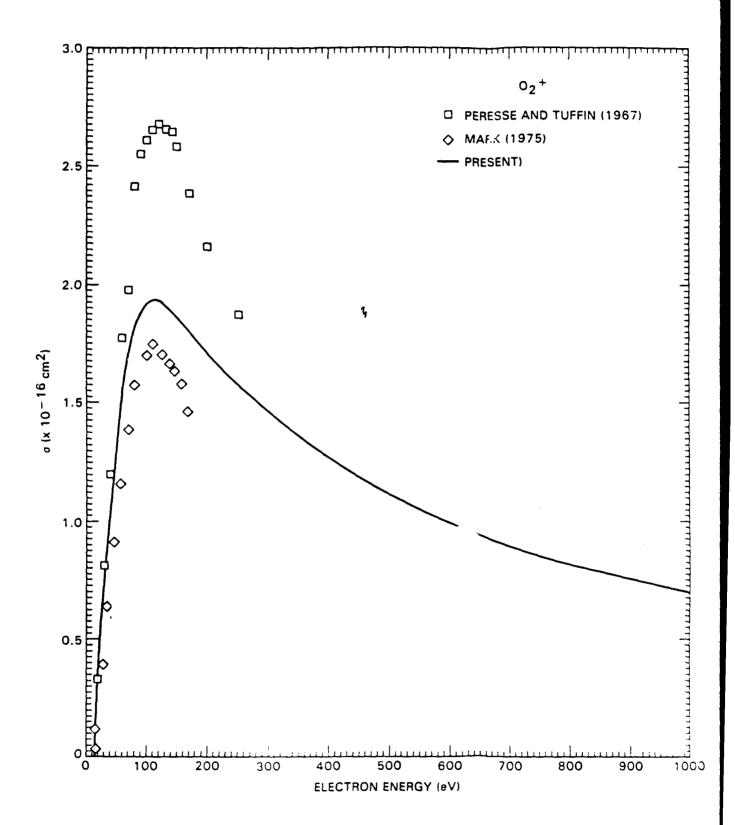


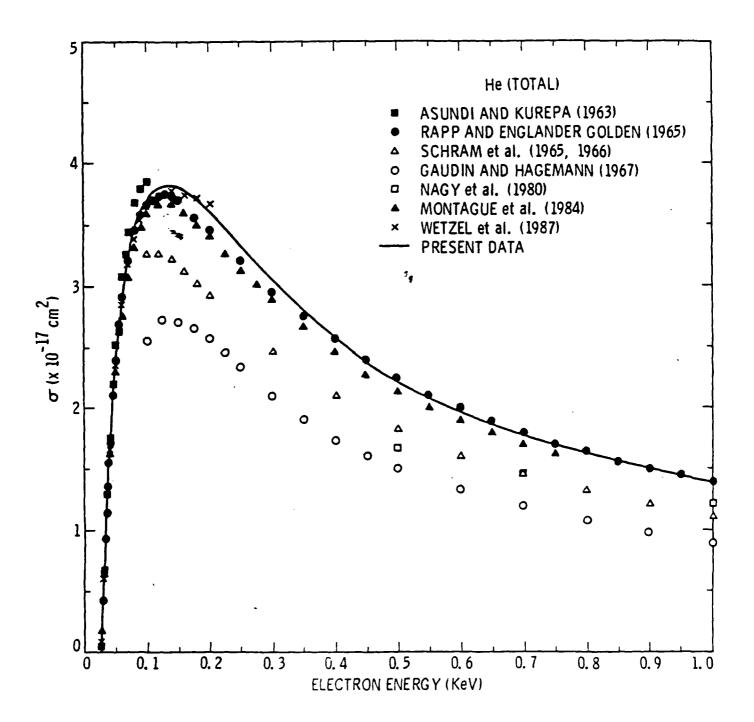


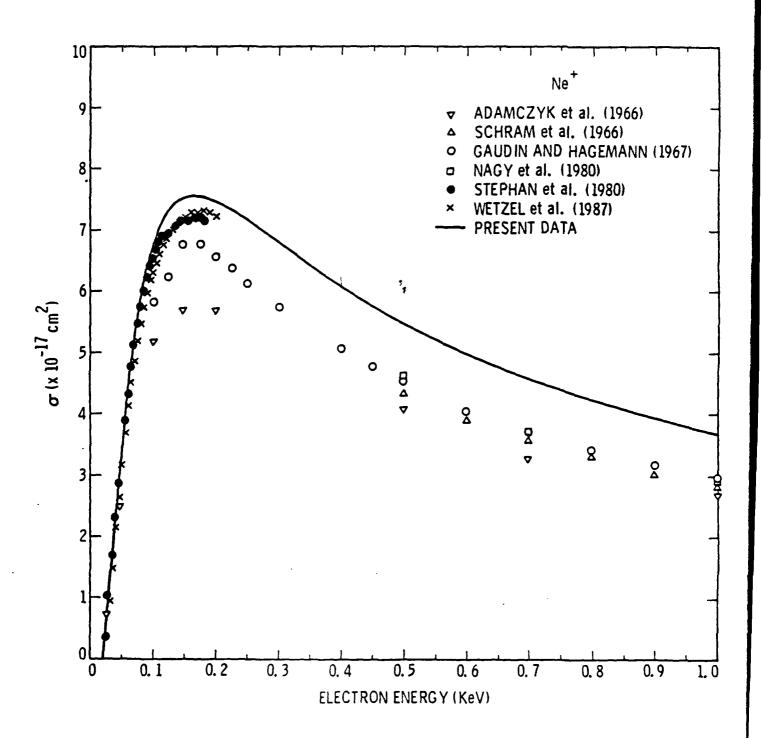


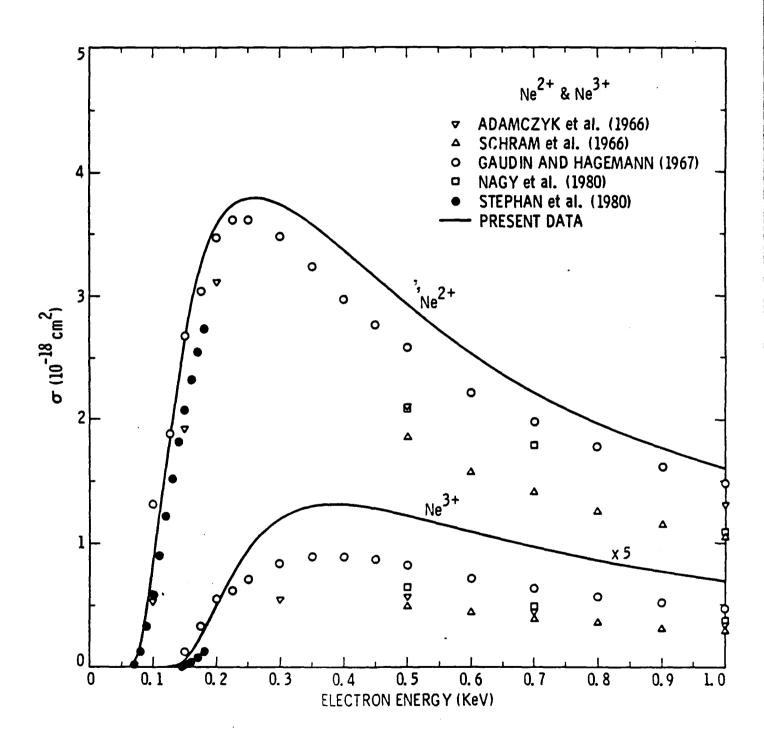
ELECTRON ENERGY (eV)

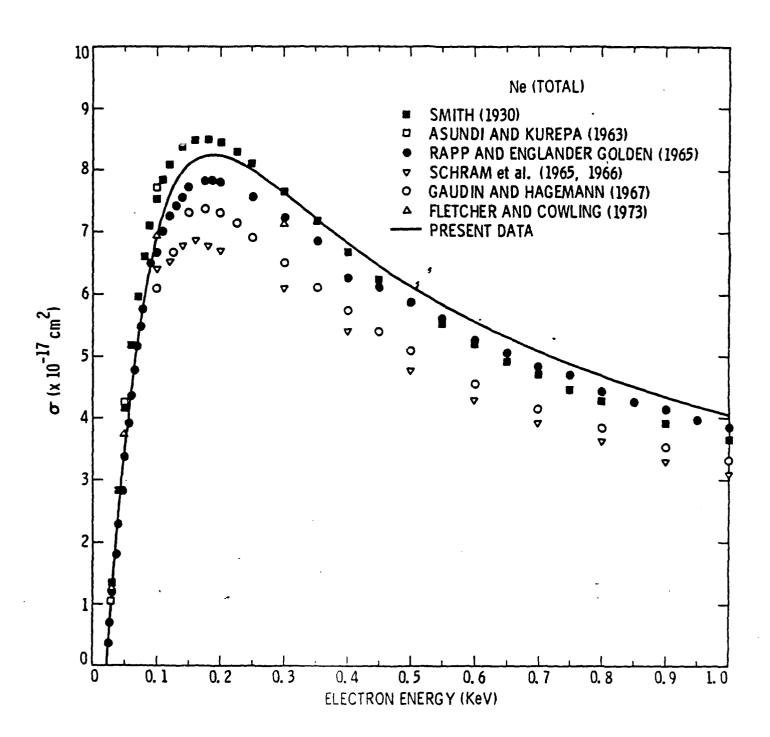


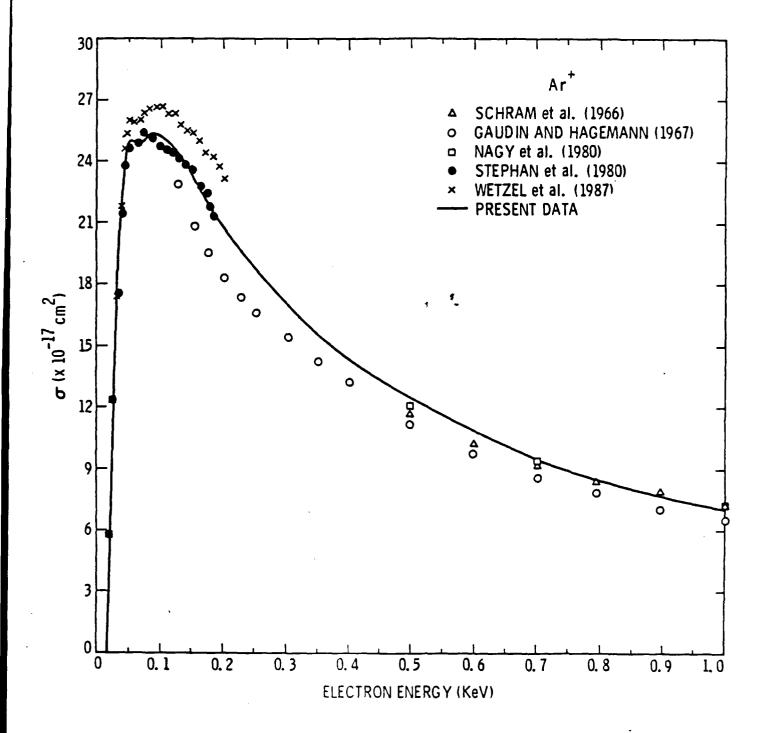


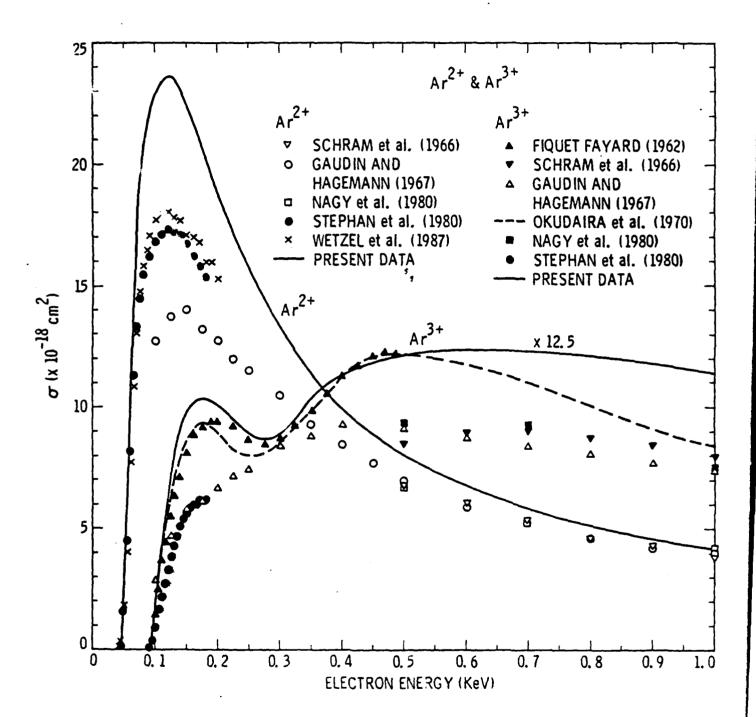


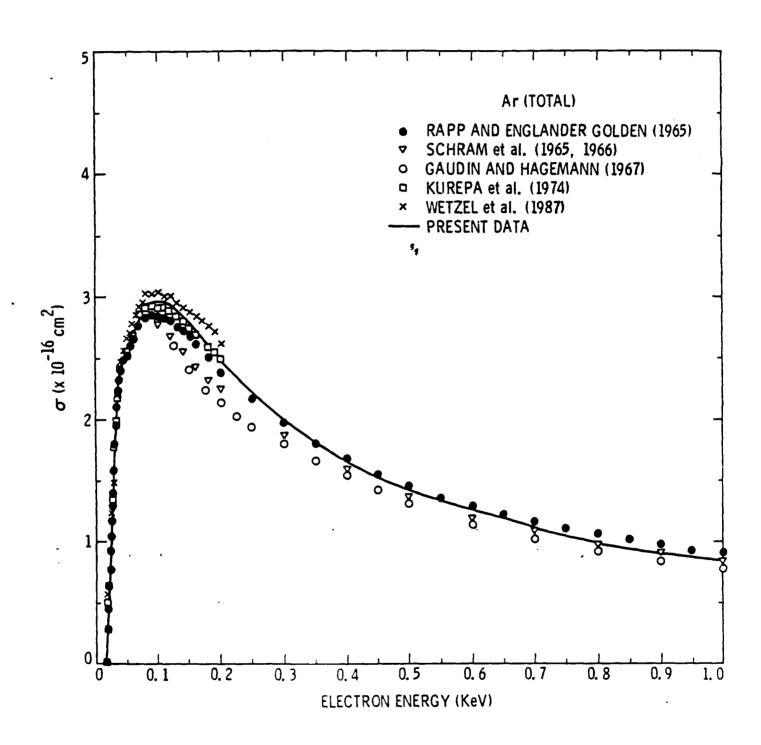


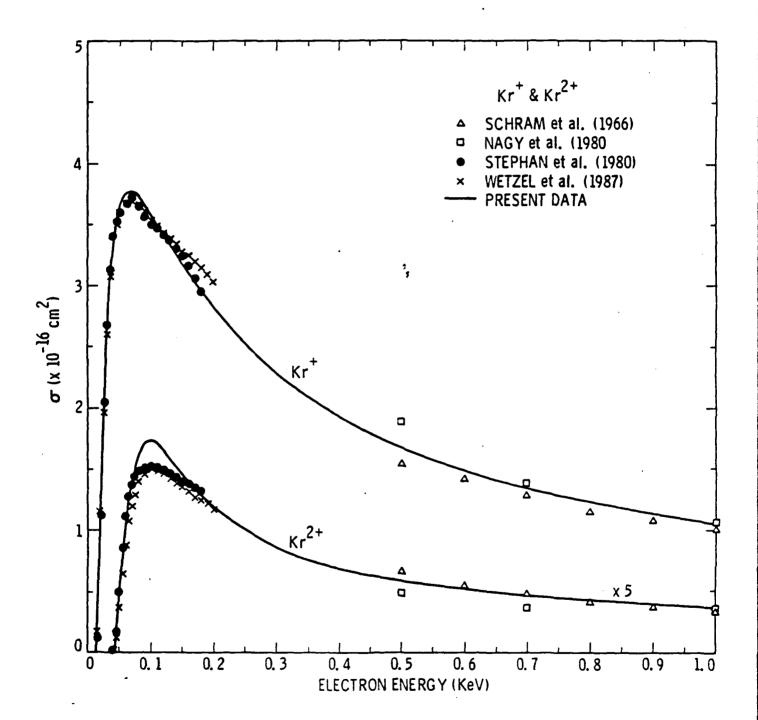


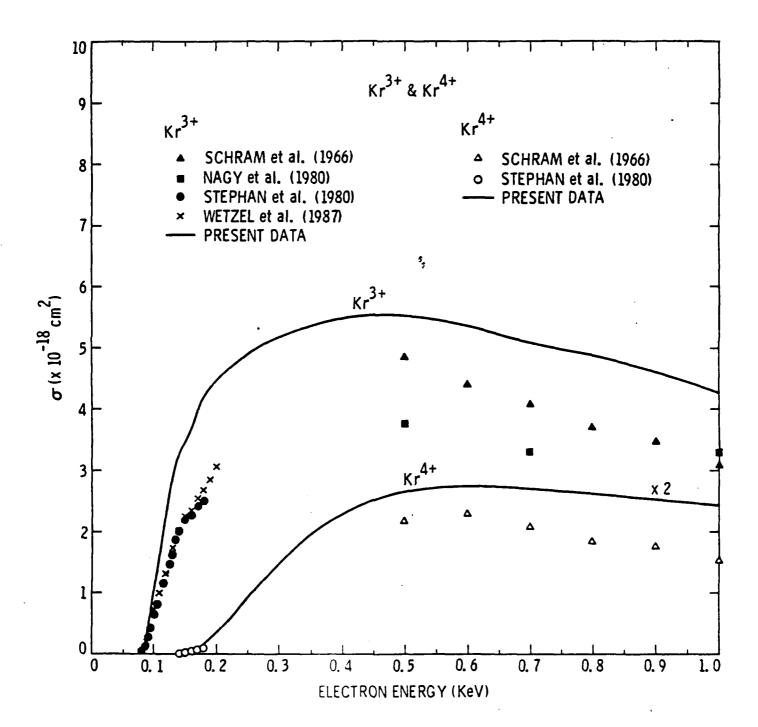


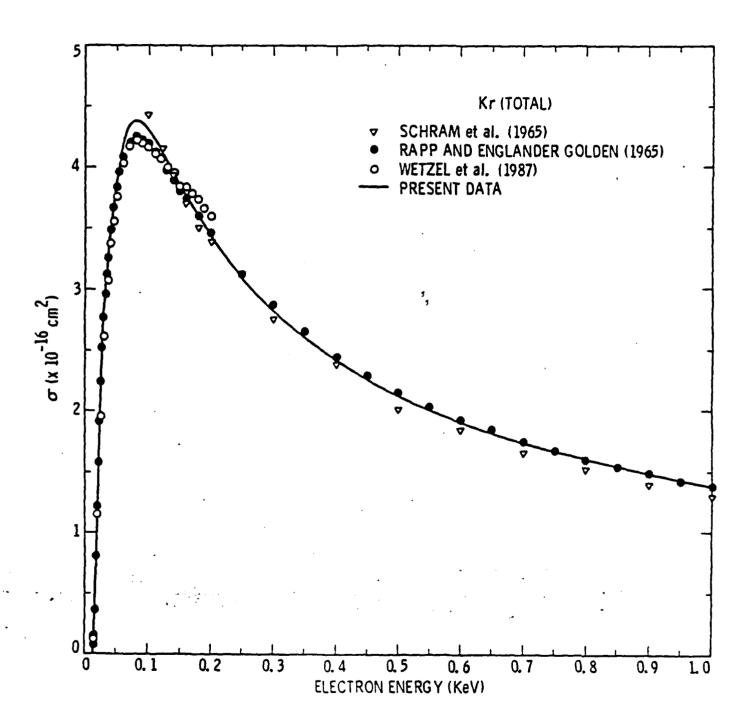


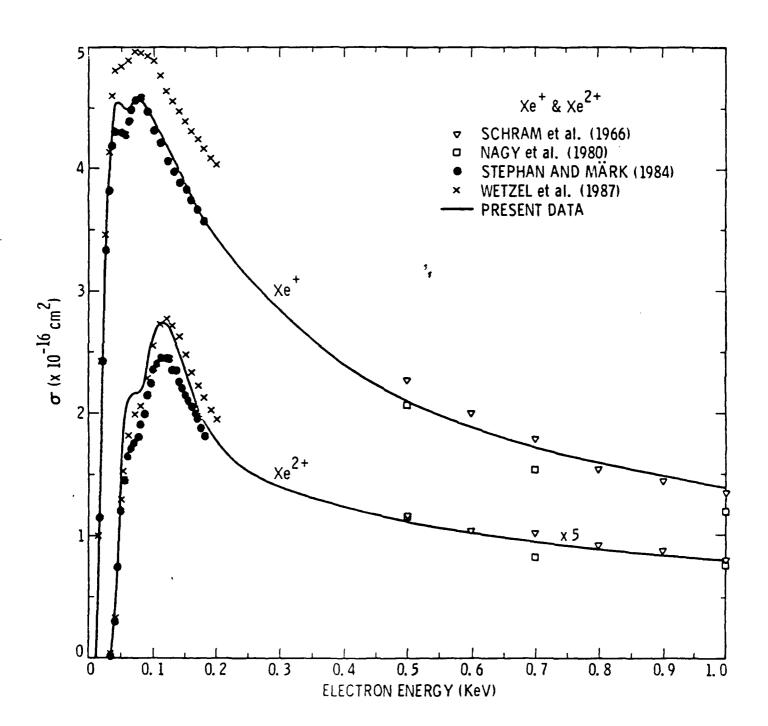


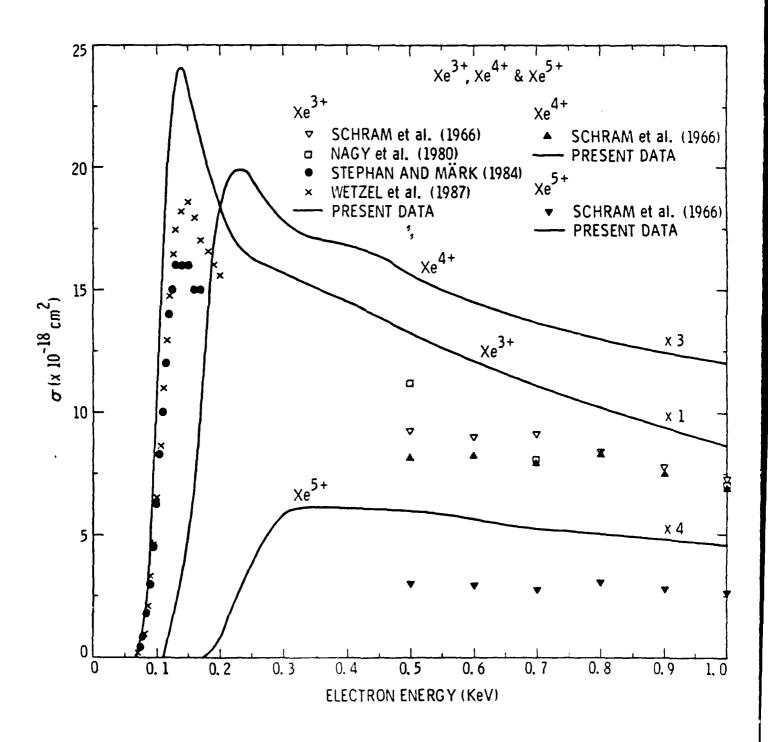


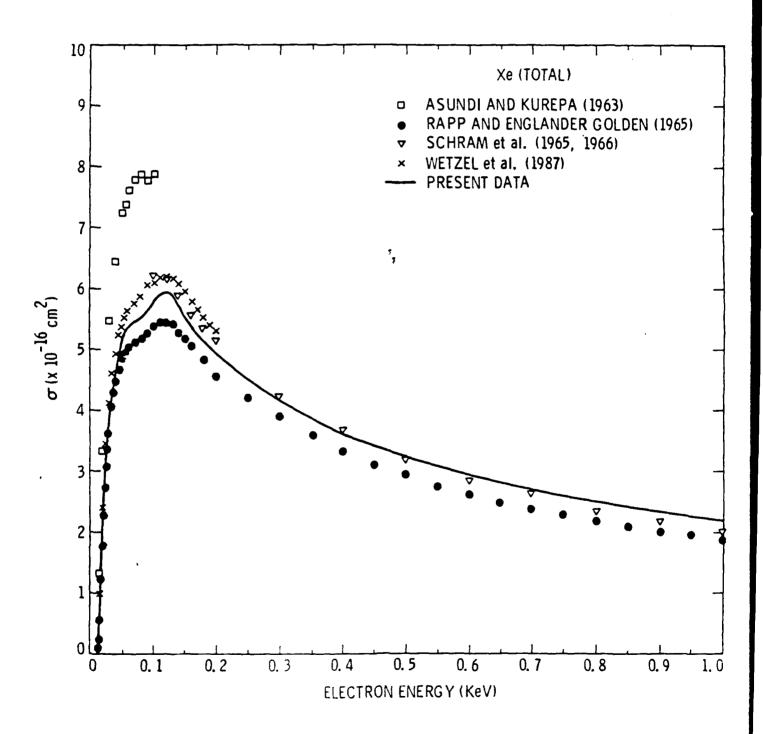


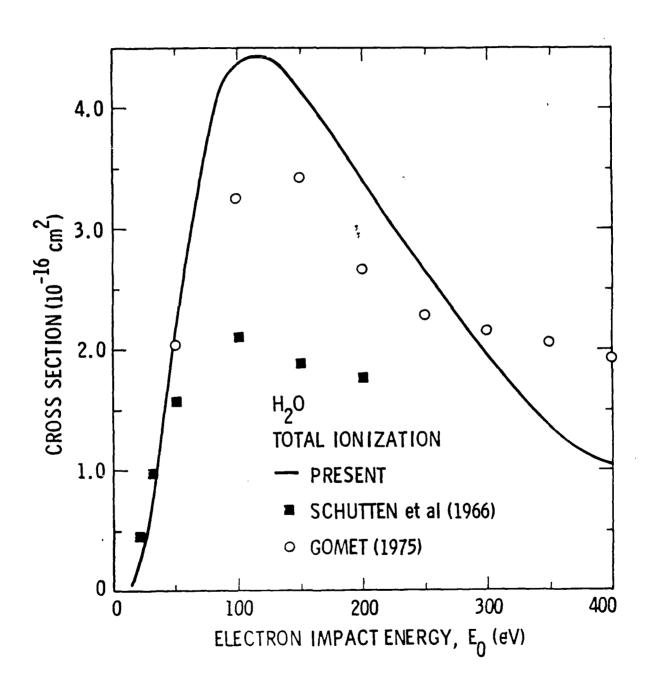


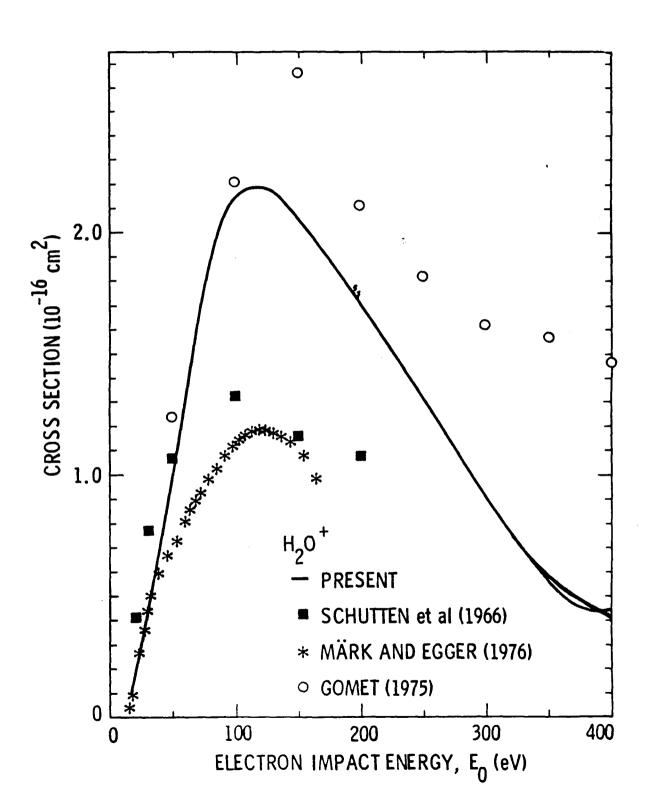


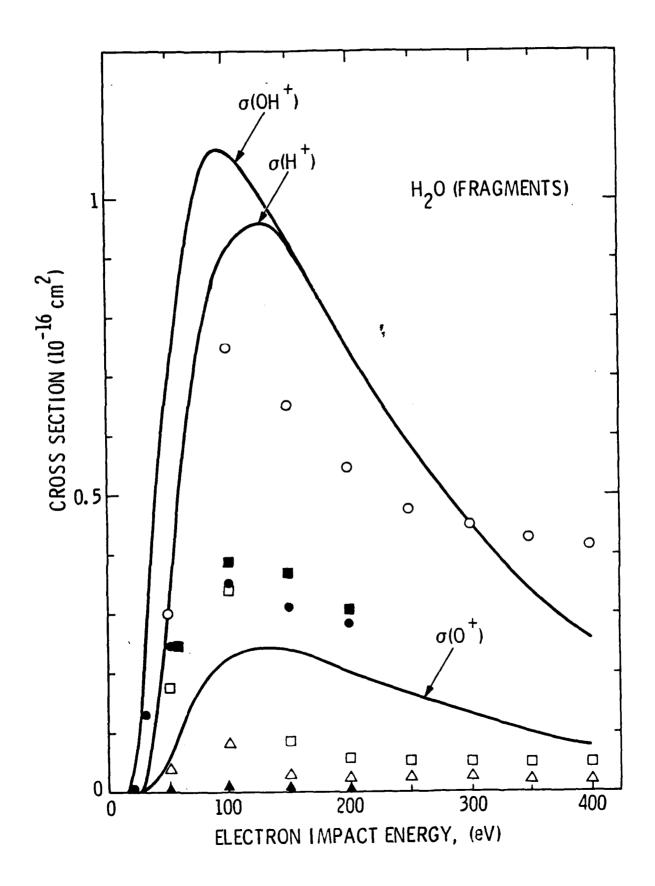


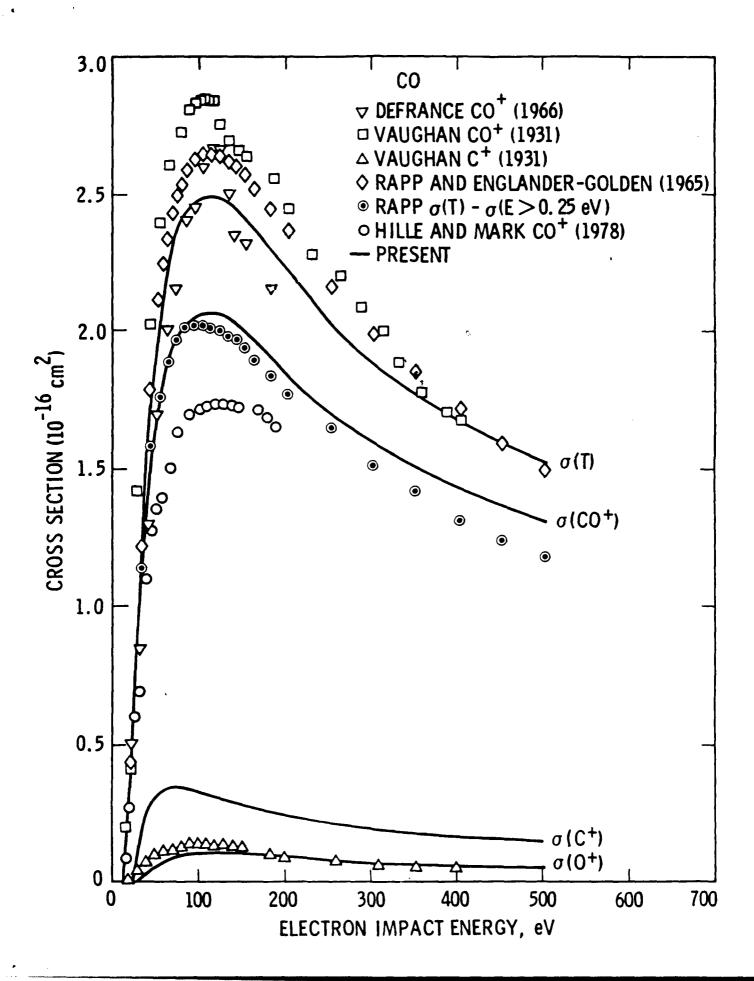


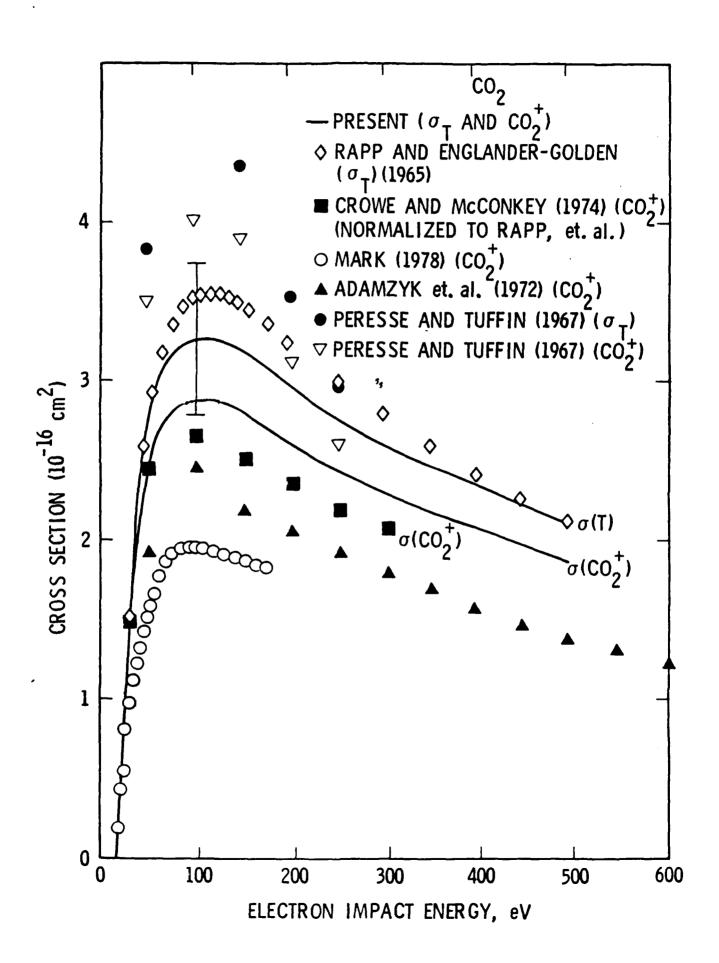


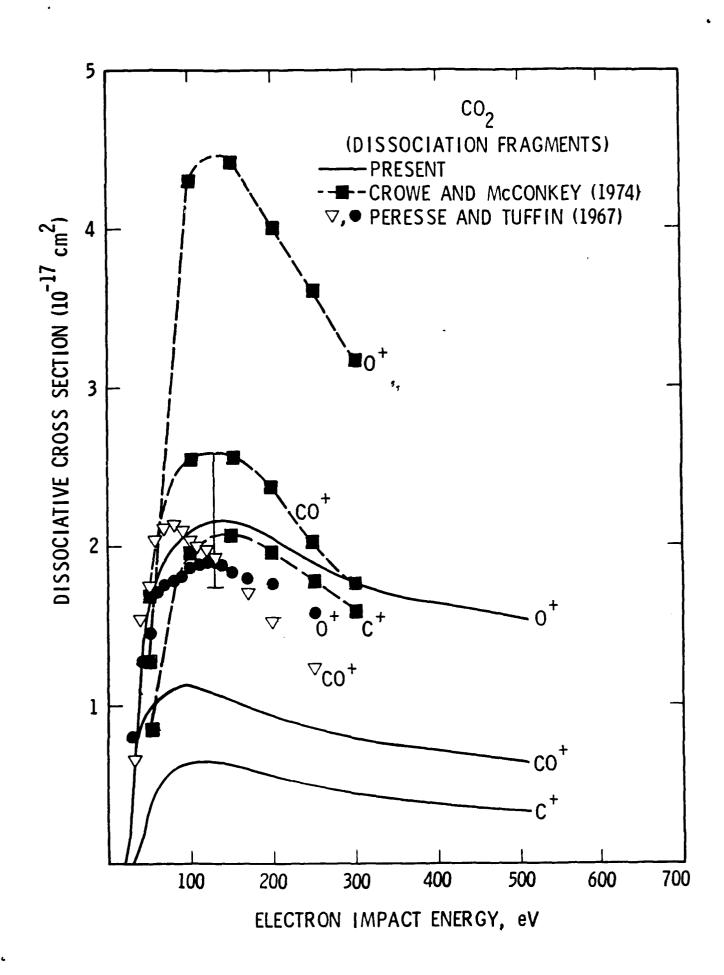


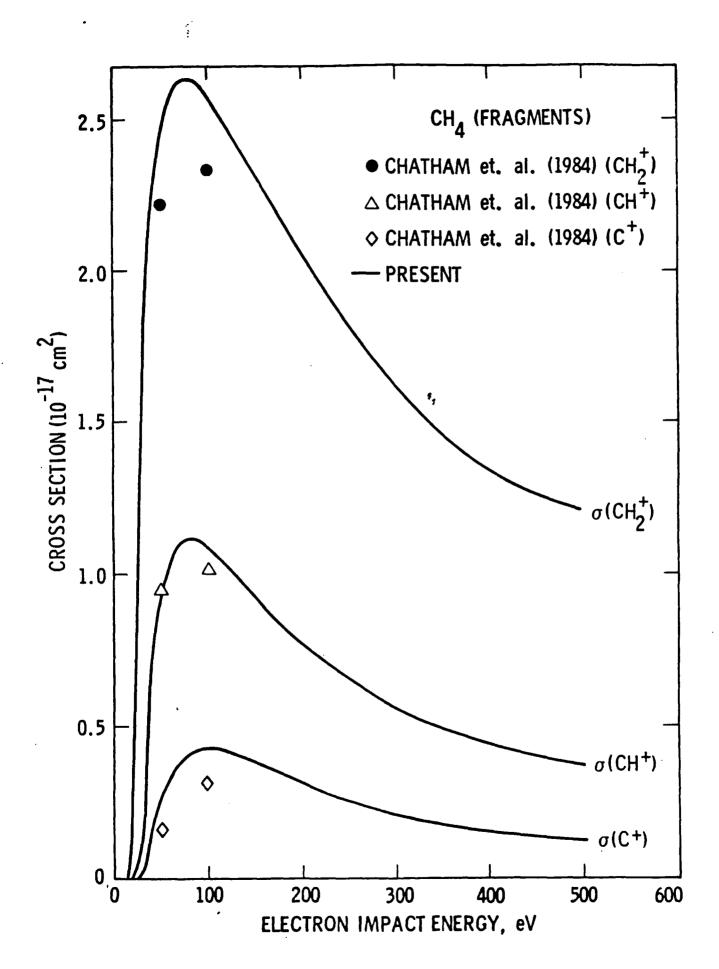


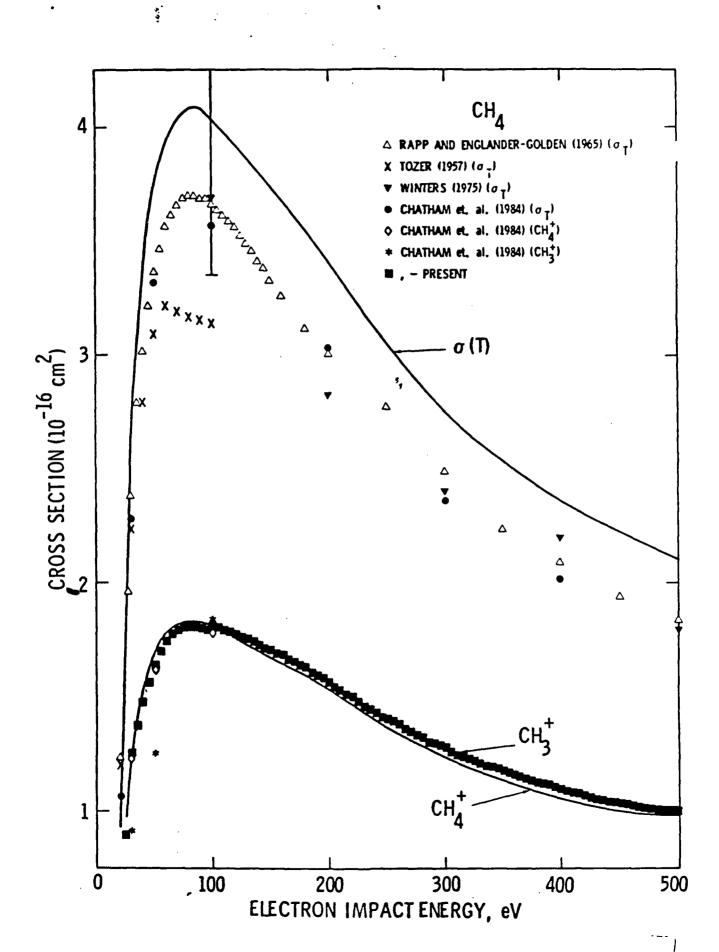


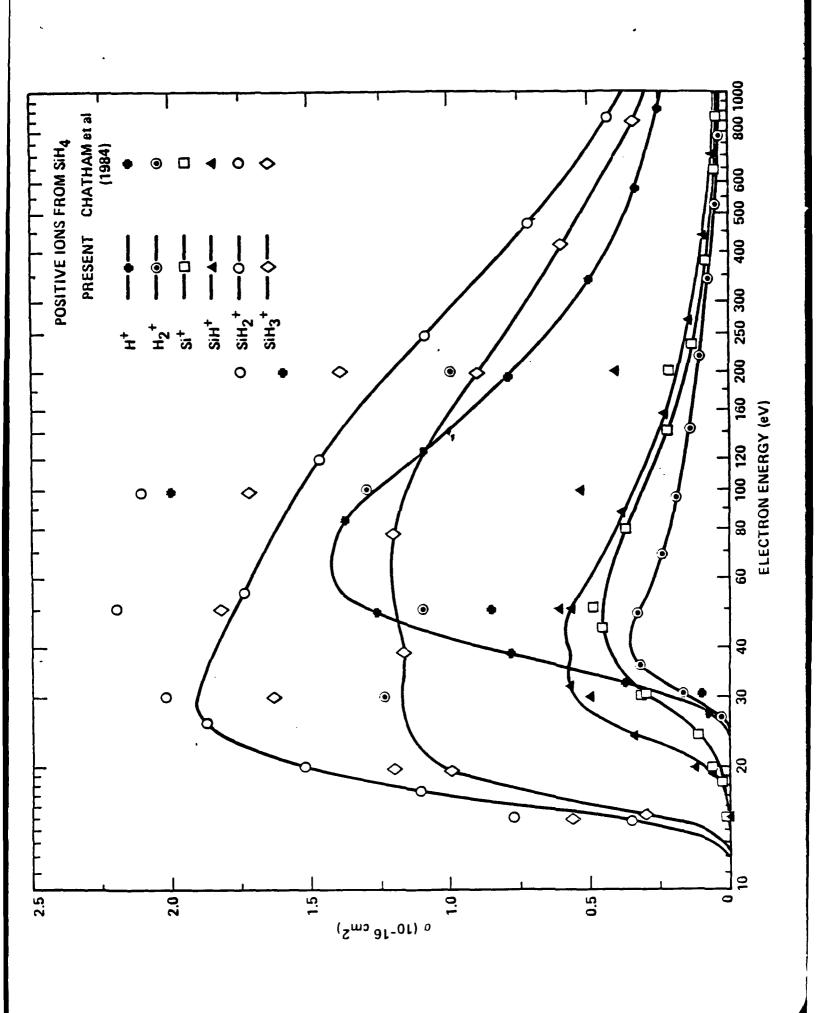


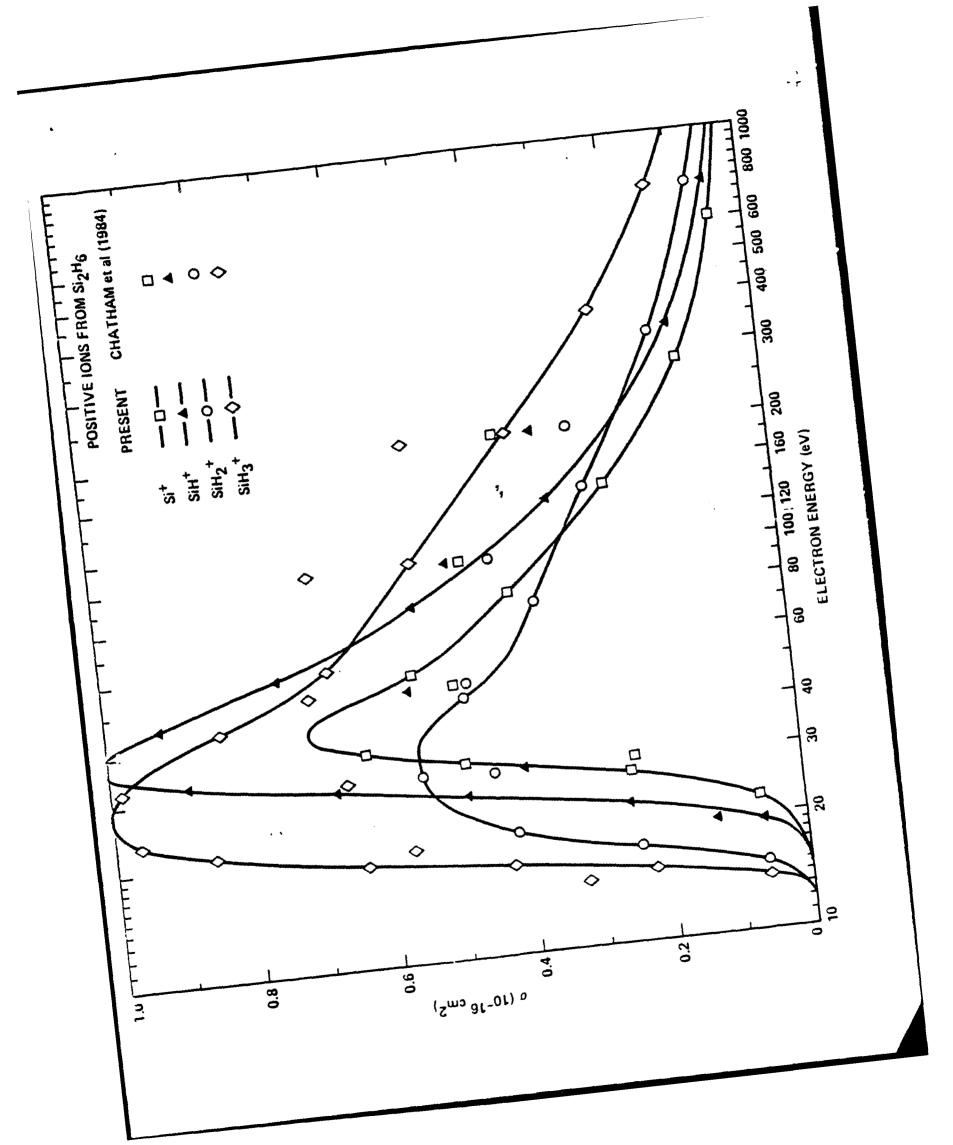


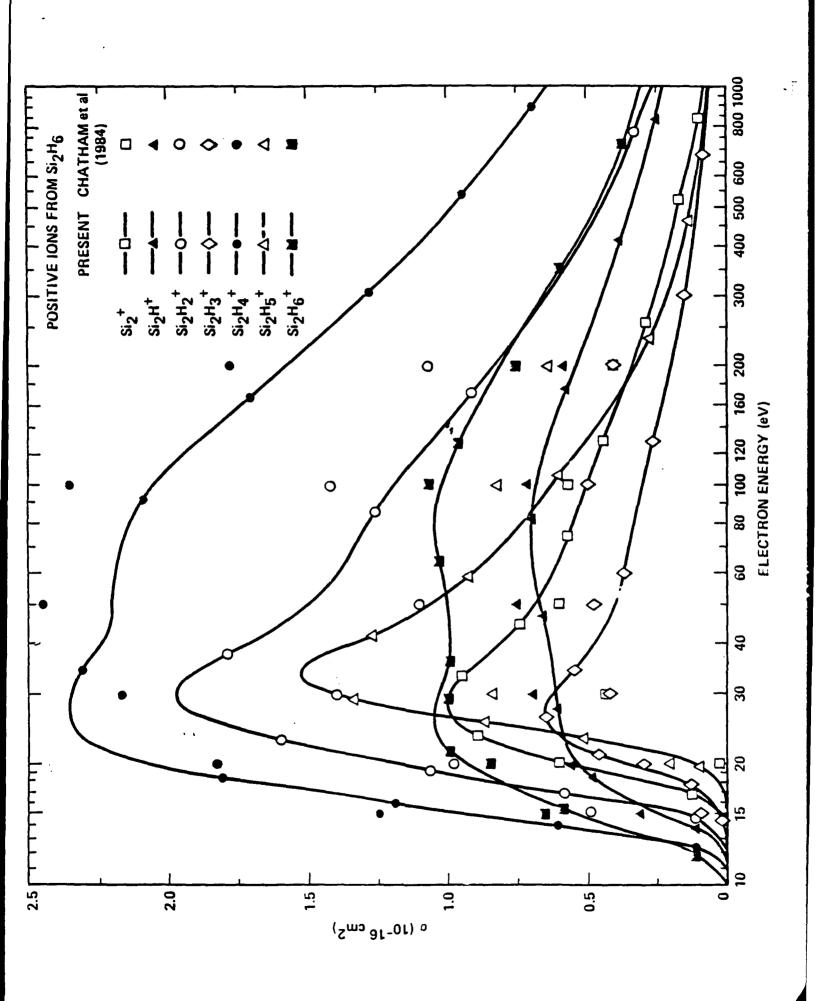


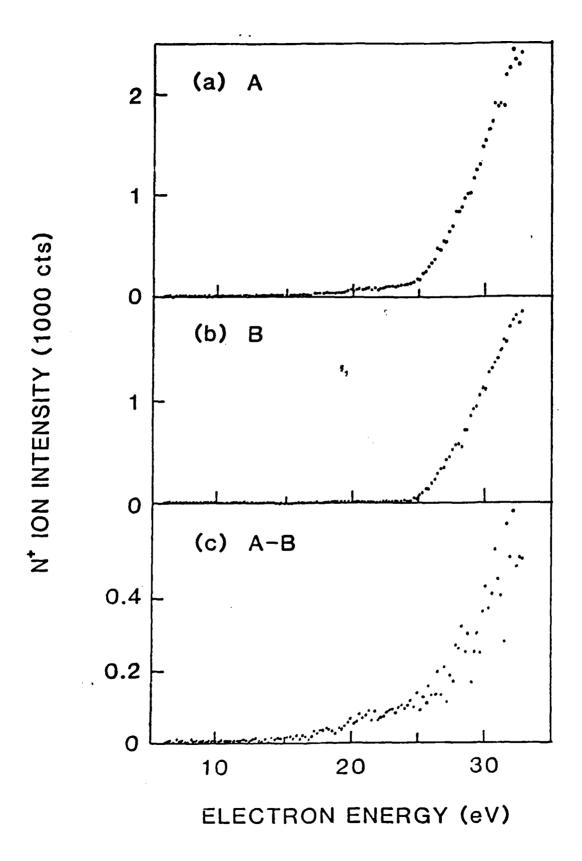












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